

isc P-Channel MOSFET Transistor

ISCD1836

• FEATURES

- Static drain-source on-resistance:
 $R_{DS(on)} \leq 4.2m\Omega (@V_{GS} = -10V; I_D = -70A)$
- Enhancement mode
- 100% avalanche tested
- Minimum Lot-to-Lot variations for robust device performance and reliable operation

• DESCRIPTION

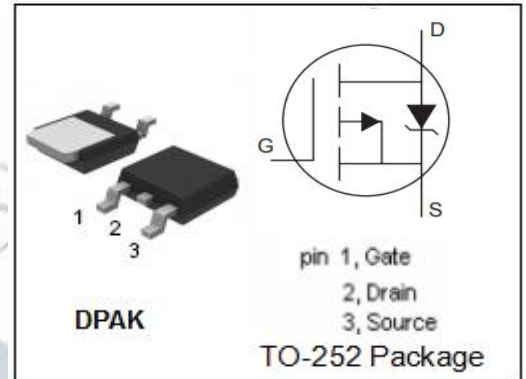
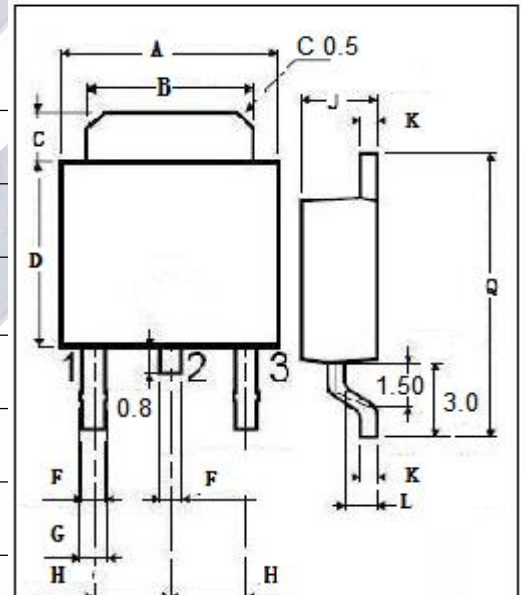
- 175° C operating junction temperature

• ABSOLUTE MAXIMUM RATINGS($T_a=25^\circ C$)

SYMBOL	PARAMETER	VALUE	UNIT
V_{DS}	Drain-Source Voltage	-30	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Drain Current-Continuous	-70	A
I_{DM}	Drain Current-Single Pulsed	-280	A
P_D	Total Dissipation @ $T_c=25^\circ C$	150	W
T_j	Max. Operating Junction Temperature	175	$^\circ C$
T_{stg}	Storage Temperature	-55~175	$^\circ C$

• THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	MAX	UNIT
$R_{th(j-c)}$	Channel-to-case thermal resistance	1.0	$^\circ C/W$
$R_{th(j-a)}$	Channel-to-ambient thermal resistance	50	$^\circ C/W$



DIM	mm	MIN	MAX
A	6.40	6.40	6.60
B	5.20	5.20	5.40
C	1.15	1.15	1.35
D	5.70	5.70	6.10
F	0.65	0.65	0.75
G	0.75	0.75	0.85
H	2.10	2.10	2.50
J	2.10	2.10	2.40
K	0.40	0.40	0.60
L	0.90	0.90	1.10
Q	9.90	9.90	10.1

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ELECTRICAL CHARACTERISTICS

 $T_C=25^{\circ}\text{C}$ unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V; I_D=-0.25mA$	-30			V
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}; I_D=-0.25mA$	-2		-1	V
$R_{DS(on)}$	Drain-Source On-Resistance	$V_{GS}=-10V; I_D=-70A$			4.2	$m\Omega$
		$V_{GS}=-4.5V; I_D=-70A$			6.8	$m\Omega$
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=-20V; V_{DS}=0V$			-100	nA
I_{DSS}	Drain-Source Leakage Current	$V_{DS}=-30V; V_{GS}=0V; T_J=25^{\circ}\text{C}$			-1	μA
		$V_{DS}=-30V; V_{GS}=0V; T_J=175^{\circ}\text{C}$			-300	μA
V_{SD}	Diode forward voltage	$I_F=-70A, V_{GS}=0V$			-1.1	V